Applicant(s)/Patent Under Application/Control No. Reexamination 10/723,361 GU ET AL. **Notice of References Cited** Art Unit Examiner Page 1 of 1 1656 David J. Steadman U.S. PATENT DOCUMENTS -**Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-Α US-В US-С US-D US-E US-F US-G US-Н US-1 US-US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification *Country Code-Number-Kind Code MM-YYYY N 0 Ρ Q R S **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) Ikura et al., PNAS 103:1159-1164, 2006 W

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